

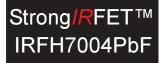


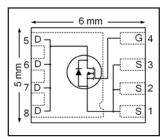
Applications

- Brushed Motor drive applications
- **BLDC** Motor drive applications
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters
- DC/AC Inverters

Benefits

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- RoHS Compliant containing no Lead, no Bromide, and no Halogen





V _{DSS}	40V
R _{DS(on)} typ.	1.1m Ω
max.	1.4m Ω
I _D (Silicon Limited)	259A①
I _{D (Package Limited)}	100A

HEXFET® Power MOSFET



Base Part Number	Package Type	Standard Pag	ck	Orderable Part Number	
		Form	Quantity		
IRFH7004PBF	PQFN 5mm x 6mm	Tape and Reel	4000	IRFH7004TRPBF	

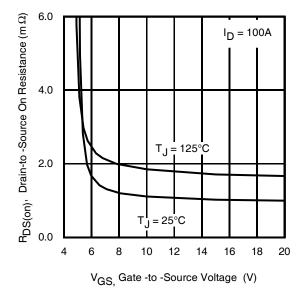


Fig 1. Typical On-Resistance vs. Gate Voltage

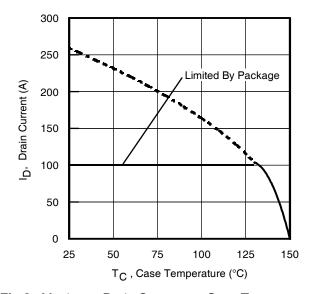


Fig 2. Maximum Drain Current vs. Case Temperature



Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	259①	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	164①	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Wire Bond Limited)	100	— A
I _{DM}	Pulsed Drain Current ②	1247	
P _D @T _C = 25°C	Maximum Power Dissipation	156	W
	Linear Derating Factor	1.3	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
T _J	Operating Junction and	-55 to + 150	20
T _{STG}	Storage Temperature Range		°C

Avalanche Characteristics

E _{AS (Thermally limited)}	Single Pulse Avalanche Energy ③	191	mJ
E _{AS (Thermally limited)}	Single Pulse Avalanche Energy ®	479	
I _{AR}	Avalanche Current ②	See Fig. 14, 15, 22a, 22b	Α
E _{AR}	Repetitive Avalanche Energy ②		mJ

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R _{0JC} (Bottom)	Junction-to-Case ®	0.5	0.8	
R _{eJC} (Top)	Junction-to-Case ®		15	°C/W
$R_{\theta JA}$	Junction-to-Ambient ®		34	-0/00
R _{0JA} (<10s)	Junction-to-Ambient ®		21	

Static @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_D = 250\mu A$
$_{\Delta}$ V _{(BR)DSS} / $_{\Delta}$ T _J	Breakdown Voltage Temp. Coefficient		0.033		V/°C	Reference to 25°C, I _D = 1.0mA ②
R _{DS(on)}	Static Drain-to-Source On-Resistance		1.1	1.4	mΩ	V _{GS} = 10V, I _D = 100A ⑤
			1.7		mΩ	$V_{GS} = 6.0V, I_D = 50A $ §
$V_{GS(th)}$	Gate Threshold Voltage	2.2	3.0	3.9	V	$V_{DS} = V_{GS}$, $I_D = 150\mu A$
I _{DSS}	Drain-to-Source Leakage Current			1.0	μΑ	$V_{DS} = 40V, V_{GS} = 0V$
				150		$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-100		V _{GS} = -20V
R _G	Internal Gate Resistance		2.4		Ω	

Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Package is limited to 100A by production test capability. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature.
- 3 Limited by T_{Jmax} , starting $T_J = 25^{\circ}C$, L = 0.038mH $R_G = 50\Omega$, $I_{AS} = 100A$, $V_{GS} = 10V$.

- ⑤ Pulse width $\leq 400\mu s$; duty cycle $\leq 2\%$.
- $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\ \$ $\$ $\ \$ $\ \$ $\$ $\ \$ $\ \$ $\$ $\$ $\$ $\$ $\ \$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$ $\$
- \odot C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- When mounted on 1 inch square 2 oz copper pad on 1.5 x 1.5 in. board of FR-4 material.
- $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \,$ $\ \ \,$ $\ \ \,$ $\ \,$ $\ \ \,$ $\ \ \,$ $\ \,$ $\ \ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$ $\ \,$
- 1 Limited by $T_{Jmax},$ starting T_{J} = 25°C, L = 1mH, $~R_{G}$ = 50 $\Omega,~I_{AS}$ = 31 A, $~V_{GS}$ =10 V.



Dynamic @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	117			S	$V_{DS} = 10V, I_{D} = 100A$
Q_g	Total Gate Charge		129	194	nC	I _D = 100A
Q_{gs}	Gate-to-Source Charge		34			V _{DS} =20V
Q_{gd}	Gate-to-Drain ("Miller") Charge		40			V _{GS} = 10V ⑤
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})		169			
t _{d(on)}	Turn-On Delay Time		15		ns	V _{DD} = 20V
t _r	Rise Time		51			I _D = 30A
t _{d(off)}	Turn-Off Delay Time		73			$R_G = 2.7\Omega$
t _f	Fall Time		49			V _{GS} = 10V ⑤
C _{iss}	Input Capacitance		6419		pF	$V_{GS} = 0V$
C _{oss}	Output Capacitance		952			V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		656			f = 1.0 MHz
C _{oss} eff. (ER)	Effective Output Capacitance (Energy Related)		1161			V _{GS} = 0V, V _{DS} = 0V to 32V ⑦
C _{oss} eff. (TR)	Effective Output Capacitance (Time Related)		1305			V _{GS} = 0V, V _{DS} = 0V to 32V ®

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I _s	Continuous Source Current			100①	Α	MOSFET symbol
	(Body Diode)					showing the
I _{SM}	Pulsed Source Current			1247	Α	integral reverse
	(Body Diode) ②					p-n junction diode.
V_{SD}	Diode Forward Voltage		0.95	1.3	V	$T_J = 25^{\circ}C$, $I_S = 100A$, $V_{GS} = 0V$ $\$$
dv/dt	Peak Diode Recovery ④		2.5		V/ns	$T_J = 175$ °C, $I_S = 100$ A, $V_{DS} = 40$ V
t _{rr}	Reverse Recovery Time		35		ns	$T_J = 25^{\circ}C$ $V_R = 34V$,
			35			$T_J = 125^{\circ}C$ $I_F = 100A$
Q _{rr}	Reverse Recovery Charge		26		nC	$T_J = 25^{\circ}C$ di/dt = 100A/µs $^{\circ}$
			27			T _J = 125°C
I _{BBM}	Reverse Recovery Current		1.5		Α	T _J = 25°C



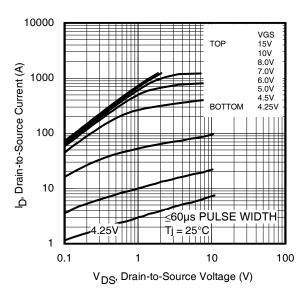


Fig 3. Typical Output Characteristics

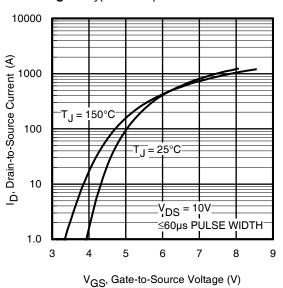


Fig 5. Typical Transfer Characteristics

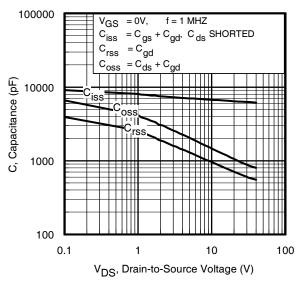


Fig 7. Typical Capacitance vs. Drain-to-Source Voltage

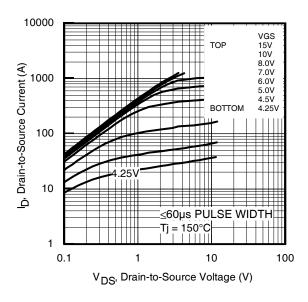


Fig 4. Typical Output Characteristics

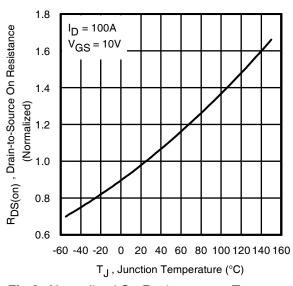


Fig 6. Normalized On-Resistance vs. Temperature

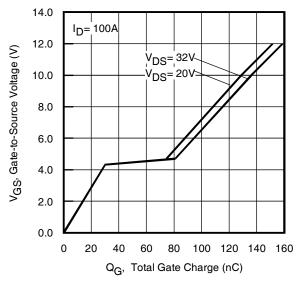
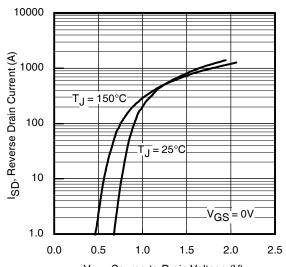


Fig 8. Typical Gate Charge vs. Gate-to-Source Voltage





V_{SD}, Source-to-Drain Voltage (V) Fig 9. Typical Source-Drain Diode Forward Voltage

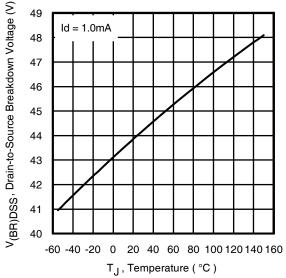


Fig 11. Drain-to-Source Breakdown Voltage

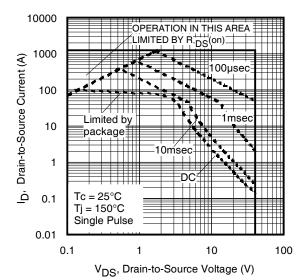


Fig 10. Maximum Safe Operating Area

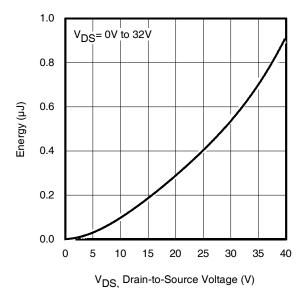


Fig 12. Typical C_{OSS} Stored Energy

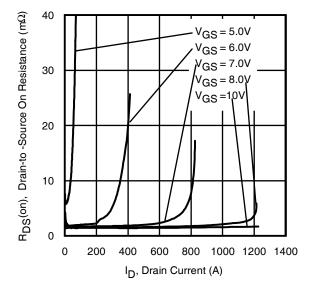


Fig 13. Typical On-Resistance vs. Drain Current

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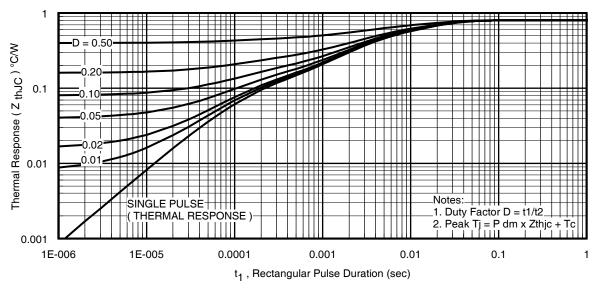


Fig 14. Maximum Effective Transient Thermal Impedance, Junction-to-Case

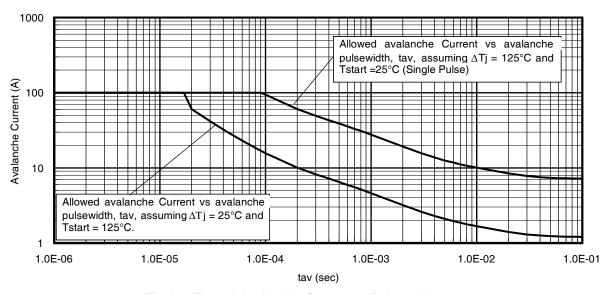


Fig 15. Typical Avalanche Current vs. Pulsewidth

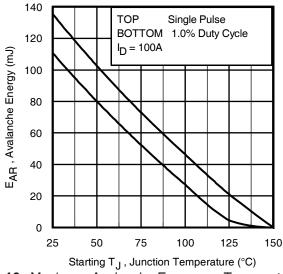


Fig 16. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in
 - excess of T_{jmax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T_{imax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4. P_{D (ave)} = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).

 t_{av} = Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D~(ave)} &= 1/2~(~1.3\text{-BV}\cdot I_{av}) = \triangle T/~Z_{thJC}\\ I_{av} &= 2\triangle T/~[1.3\text{-BV}\cdot Z_{th}]\\ E_{AS~(AR)} &= P_{D~(ave)}\cdot t_{av} \end{split}$$



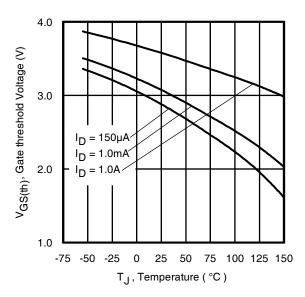


Fig 17. Threshold Voltage vs. Temperature

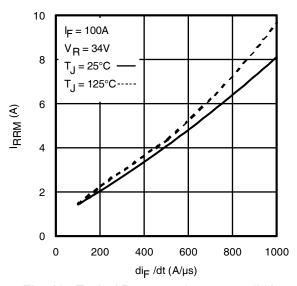


Fig. 19 - Typical Recovery Current vs. dif/dt

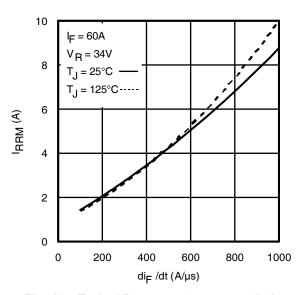


Fig. 18 - Typical Recovery Current vs. di_f/dt

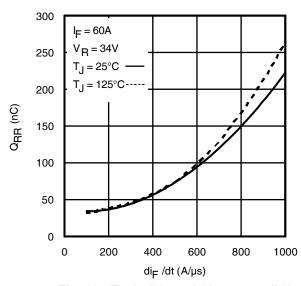


Fig. 20 - Typical Stored Charge vs. dif/dt

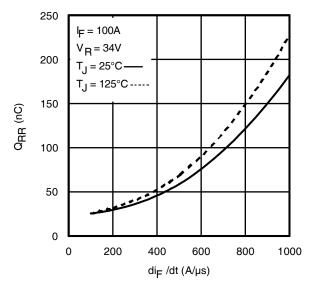


Fig. 21 - Typical Stored Charge vs. di_f/dt

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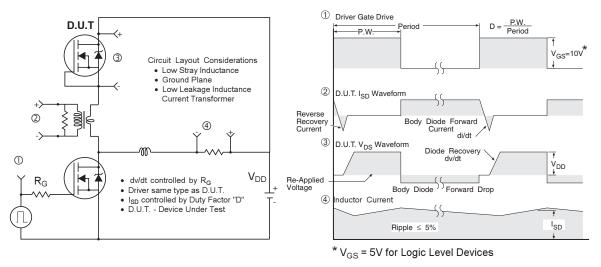


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

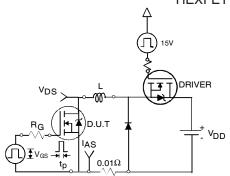


Fig 22a. Unclamped Inductive Test

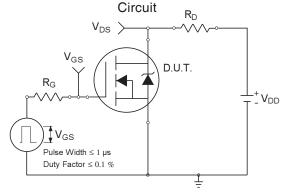


Fig 23a. Switching Time Test Circuit

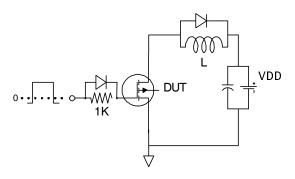


Fig 24a. Gate Charge Test Circuit

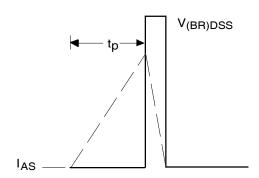


Fig 22b. Unclamped Inductive Waveforms

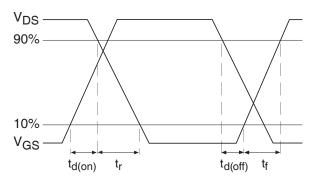


Fig 23b. Switching Time Waveforms

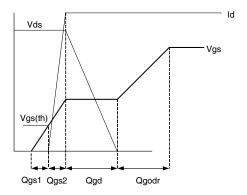
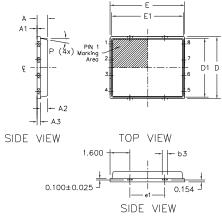


Fig 24b. Gate Charge Waveform



PQFN 5x6 Outline "B" Package Details



0.422 - K	
R2 — C0.395	
7 P P P P P P P P P P P P P P P P P P P	
5 7 4 4	
Expose - E4 - b (8x) - E2 L (4x)	
BOTTOM VIEW	

DIM	MILLIM	IITERS	IN	ICH	
SYMBOL	MIN	MAX	MIN	MAX	
А	0.800	0.900	0.0315	0.0543	
A1	0.000	0.050	0.0000	0.0020	
A3	0.20	0 REF	0.007	'9 REF	
b	0.350	0.470	0.0138	0.0185	
b1	0.025	0.125	0.0010	0.0049	
b2	0.210	0.410	0.0083	0.0161	
b3	0.150	0.450	0.0059	0.0177	
D	5.000	O BSC	0.1969 BSC		
D1	4.750	O BSC	0.1870 BSC		
D2	4.100	4.300	0.1614	0.1693	
Е	6.000	O BSC	0.2362 BSC		
E1	5.75	O BSC	0.2264 BSC		
E2	3.380	3.780	0.1331	0.1488	
е	1.27	70 REF	0.05	OO REF	
e1	2.80	O REF	0.11	02 REF	
K	1.200	1.420	0.0472	0.0559	
L	0.710	0.900	0.0280	0.0354	
Р	0,	12°	0,	12°	
R	0.200	0.200 REF 0.0079		9 REF	
R2	0.150	0.200	0.0059	0.0079	

Note:

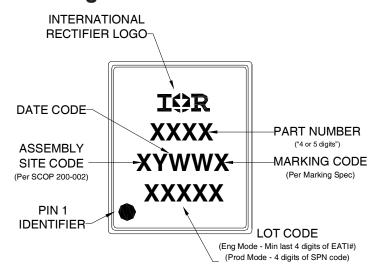
- Dimensions and toleranceing confirm to ASME Y14,5M-1994
- acceptable
- Coplanarity applies to the expose Heat Slug as well as the terminal
- 4, Radius on terminal is Optional

For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: http://www.irf.com/technical-info/appnotes/an-1136.pdf

For more information on package inspection techniques, please refer to application note AN-1154:

http://www.irf.com/technical-info/appnotes/an-1154.pdf

PQFN 5x6 Part Marking



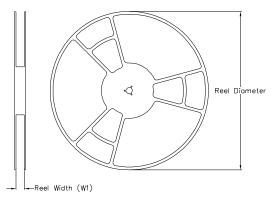
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Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/

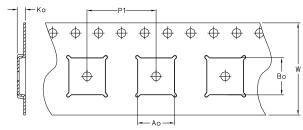


PQFN 5x6 Tape and Reel

REEL DIMENSIONS

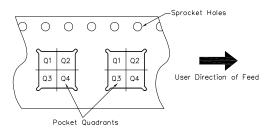


TAPE DIMENSIONS



CODE	DESCRIPTION
Ao	Dimension design to accommodate the component width
	,
Во	Dimension design to accommodate the component lenght
Ко	Dimension design to accommodate the component thickness
W	Overall wiath of the carrier tape
Pη	Pitch between successive covity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Note: All dimension are nominal

Package Type	Reel Diameter (Inch)	QTY	Reel Width W1 (mm)	Ao (mm)	Bo (mm)	Ko (mm)	P1 (mm)	W (mm)	Pin 1 Quadrant
5 X 6 PQFN	13	4000	12.4	6.300	5.300	1.20	8.00	12	ରୀ

Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/



Qualification information[†]

Qualification level	Industrial	
	(per JEDEC JESD47F ^{††} guidelines)	
Moisture Sensitivity Level	PQFN 5mm x 6mm	MSL1
		(per JEDEC J-STD-020D ^{††})
RoHS compliant	Yes	

- Qualification standards can be found at International Rectifier's web site: http://www.irf.com/product-info/reliability/
- †† Applicable version of JEDEC standard at the time of product release.

Revision History

Date	Comment	
2/19/2015	Updated E _{AS (L =1mH)} = 479mJ on page 2	
	• Updated note 10 "Limited by T_{Jmax} , starting $T_J = 25$ °C, $L = 1$ mH, $R_G = 50\Omega$, $I_{AS} = 31$ A, $V_{GS} = 10$ V". on page 2	
3/17/2015	Updated package outline and tape and reel on pages 9 and 10.	

